

RoHS Compliant Product
A suffix of "-C" specifies halogen-free

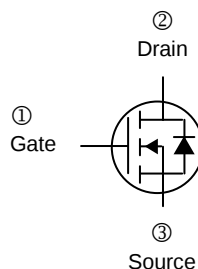
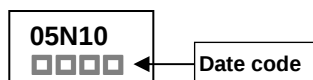
DESCRIPTION

The SID05N10 provide the designer with the best combination of fast switching, The TO-251 package is universally preferred for all commercial-industrial surface mount applications. The device is suited for charger, industrial and consumer environment.

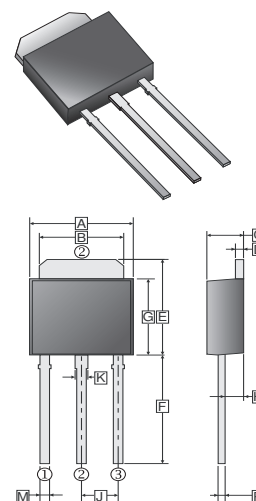
FEATURES

- Low On-resistance
- Fast Switching Speed
- Low-voltage drive (4V)
- Wide SOA (safe operating area)
- Easily designed drive circuits
- Easy to parallel

MARKING:



TO-251



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	6.40	6.80	G	5.40	5.80
B	5.20	5.50	H	0.90	1.50
C	2.20	2.40	J	2.30	
D	0.45	0.55	K	0.60	0.90
E	6.80	7.20	M	0.50	0.70
F	7.20	7.80	P	0.45	0.60

ABSOLUTE MAXIMUM RATINGS

Parameter		Symbol	Ratings	Unit
Drain-Source Voltage		V_{DS}	100	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current	$T_C=25^\circ\text{C}$	I_D	5	A
	$T_C=100^\circ\text{C}$		3.75	A
Pulsed Drain Current ¹		I_{DM}	20	A
Total Power Dissipation @ $T_C = 25^\circ\text{C}$		P_D	20	W
Thermal Resistance Junction-case		$R_{\theta JC}$	6.25	$^\circ\text{C} / \text{W}$
Thermal Resistance Junction-ambient		$R_{\theta JA}$	110	$^\circ\text{C} / \text{W}$
Linear Derating Factor			0.16	$\text{W} / ^\circ\text{C}$
Operating Junction & Storage temperature		T_J, T_{STG}	-55~150	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_J=25^{\circ}\text{C}$ unless otherwise specified)

Parameter		Symbol	Min	Typ	Max	Unit	Test Conditions
Drain-Source Breakdown Voltage		BV _{DSS}	100	-	-	V	V _{GS} =0, I _D =1mA
Gate Threshold Voltage		V _{GS(th)}	1	-	2.5	V	V _{DS} =10V, I _D =1mA
Forward Trans-conductance		g _{fs}	-	4	-	S	V _{DS} =10V, I _D =2.5A
Gate-Source Leakage Current		I _{GSS}	-	-	±100	nA	V _{GS} = ±20V
Drain-Source Leakage Current	T _J =25°C	I _{DSS}	-	-	10	uA	V _{DS} =100 V, V _{GS} =0
Static Drain-Source On-Resistance ²		R _{DS(ON)}	-	-	170	mΩ	V _{GS} =10 V, I _D =2.5A
			-	-	200		V _{GS} =4V, I _D =2.5A
Turn-on Delay Time ²		T _{d(on)}	-	9	-	nS	V _{DD} =30V I _D =1A V _{GS} =10 V R _G =6Ω R _L =30Ω
Rise Time		T _r	-	9.4	-		
Turn-off Delay Time		T _{d(off)}	-	26.8	-		
Fall Time		T _f	-	2.6	-		
Input Capacitance		C _{iss}	-	975	-	pF	V _{GS} =0 V _{DS} =25V f =1 MHz
Output Capacitance		C _{oss}	-	38	-		
Reverse Transfer Capacitance		C _{rss}	-	27	-		
Source-Drain Diode							
Forward On Voltage ²		V _{SD}	-	-	1.5	V	I _S =5A, V _{GS} =0 ,T _J =25 °C

Notes:

1. Pulse width limited by maximum junction temperature.
2. Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$

CHARACTERISTIC CURVES

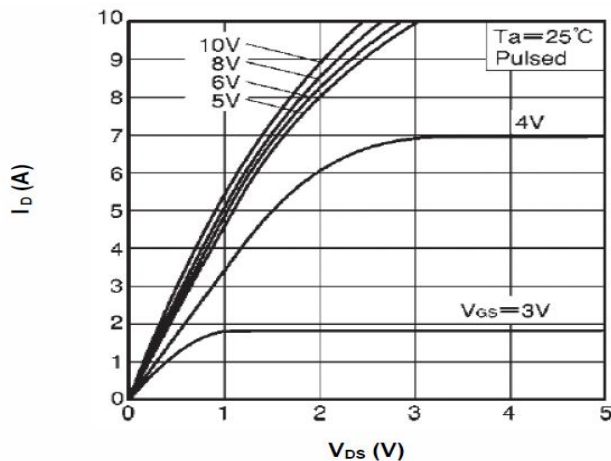


Fig 1. Typical Output Characteristics

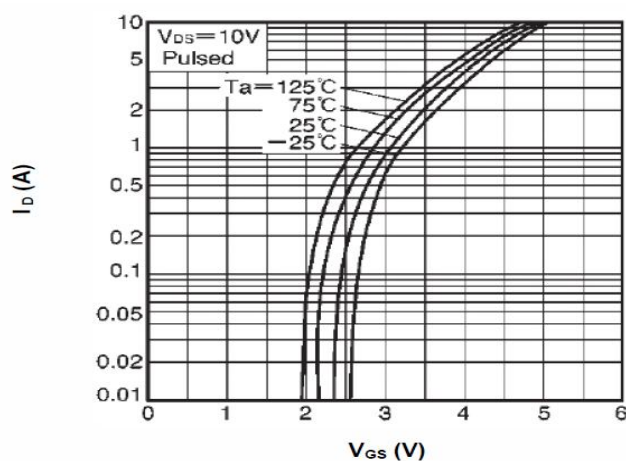
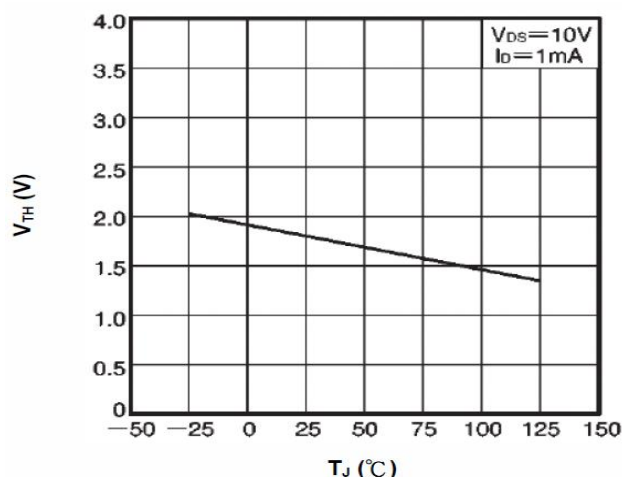
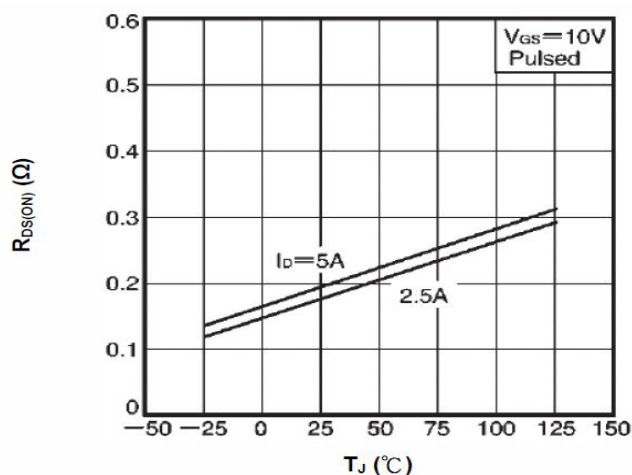


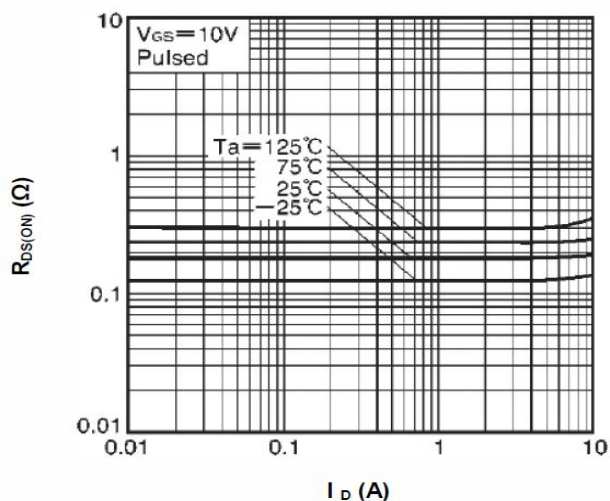
Fig 2. Transfer Characteristics



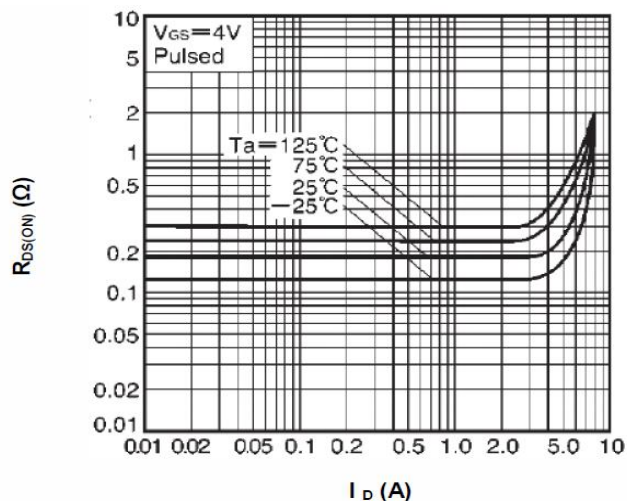
**Fig 3. Gate Threshold Voltage
vs. Junction Temperature**



**Fig 4. On-Resistance
vs. Junction Temperature**



**Fig 5. On-Resistance
vs. Drain Current (I)**



**Fig 6. On-Resistance
vs. Drain Current (II)**

CHARACTERISTIC CURVES

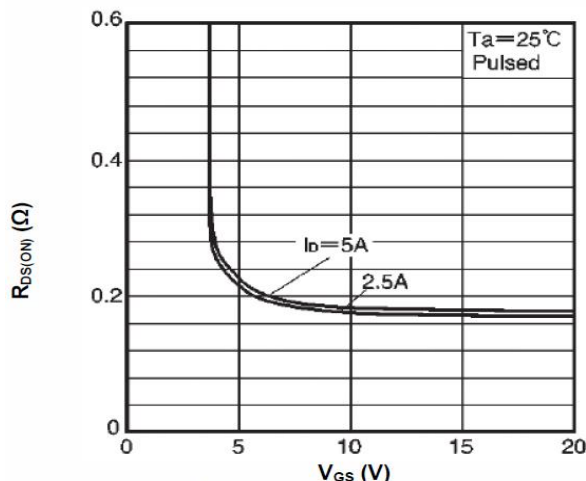


Fig 7. On-Resistance vs. Gate-Source Voltage

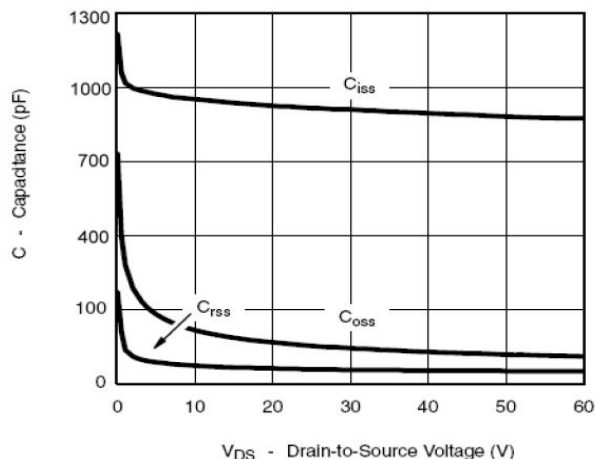


Fig 8. Typical Capacitance Characteristics

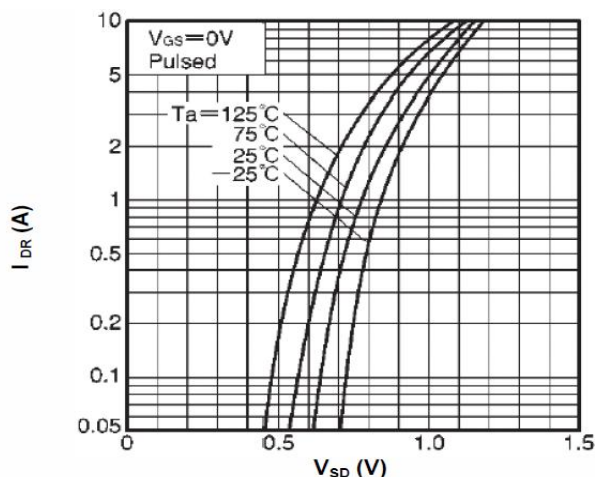


Fig 9. Reverse Drain Current vs. Source-Drain Voltage (I)

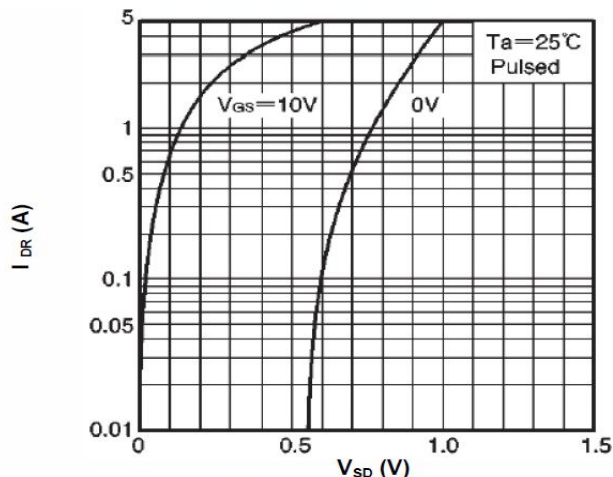


Fig 10. Reverse Drain Current vs. Source-Drain Voltage (II)

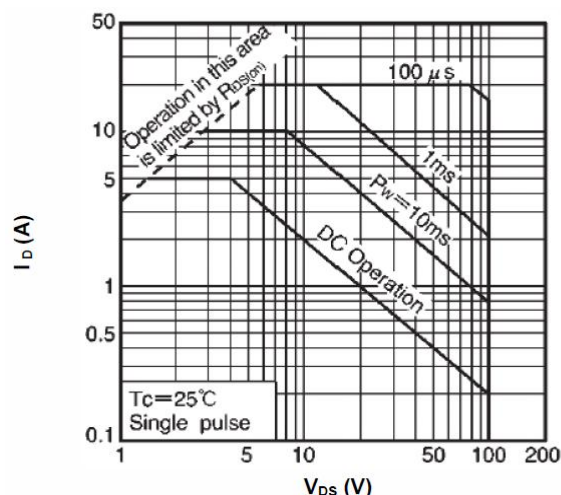


Fig 11. Maximum Safe Operating Area

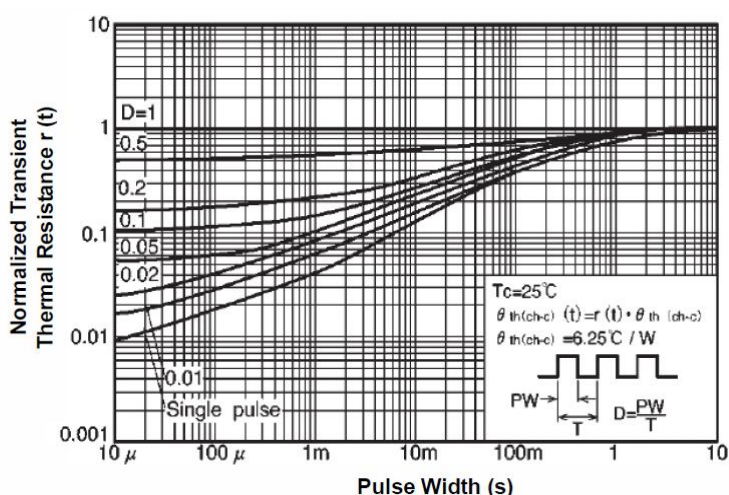


Fig 12. Normalized Transient Thermal Resistance vs. Pulse Width